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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Obsolete
Number of LABs/CLBs	11519
Number of Logic Elements/Cells	147443
Total RAM Bits	4939776
Number of I/O	540
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	900-BBGA
Supplier Device Package	900-FBGA (31x31)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc6slx150t-n3fgg900c">https://www.e-xfl.com/product-detail/xilinx/xc6slx150t-n3fgg900c</a>

## Quiescent Current

Typical values for quiescent supply current are specified at nominal voltage, 25°C junction temperatures ( $T_j$ ). Quiescent supply current is specified by speed grade for Spartan-6 devices. Xilinx recommends analyzing static power consumption using the XPOWER™ Estimator (XPE) tool (download at <http://www.xilinx.com/power>) for conditions other than those specified in Table 5.

Table 5: Typical Quiescent Supply Current

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
$I_{CCINTQ}$	Quiescent $V_{CCINT}$ supply current	LX4	4.0	4.0	4.0	2.4	mA
		LX9	4.0	4.0	4.0	2.4	mA
		LX16	6.0	6.0	6.0	4.0	mA
		LX25	11.0	11.0	11.0	6.6	mA
		LX25T	11.0	11.0	11.0	N/A	mA
		LX45	15.0	15.0	15.0	9.0	mA
		LX45T	15.0	15.0	15.0	N/A	mA
		LX75	29.0	29.0	29.0	17.4	mA
		LX75T	29.0	29.0	29.0	N/A	mA
		LX100	36.0	36.0	36.0	21.6	mA
		LX100T	36.0	36.0	36.0	N/A	mA
		LX150	51.0	51.0	51.0	31.0	mA
		LX150T	51.0	51.0	51.0	N/A	mA
$I_{CCOQ}$	Quiescent $V_{CCO}$ supply current	LX4	1.0	1.0	1.0	1.0	mA
		LX9	1.0	1.0	1.0	1.0	mA
		LX16	2.0	2.0	2.0	2.0	mA
		LX25	2.0	2.0	2.0	2.0	mA
		LX25T	2.0	2.0	2.0	N/A	mA
		LX45	3.0	3.0	3.0	3.0	mA
		LX45T	3.0	3.0	3.0	N/A	mA
		LX75	4.0	4.0	4.0	4.0	mA
		LX75T	4.0	4.0	4.0	N/A	mA
		LX100	5.0	5.0	5.0	5.0	mA
		LX100T	5.0	5.0	5.0	N/A	mA
		LX150	7.0	7.0	7.0	7.0	mA
		LX150T	7.0	7.0	7.0	N/A	mA

In [Table 9](#) and [Table 10](#), values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

**Table 9: Single-Ended I/O Standard DC Input and Output Levels**

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	$V$ , Min	$V$ , Max	$V$ , Min	$V$ , Max	$V$ , Max	$V$ , Min	mA	mA
LVTTL	-0.5	0.8	2.0	4.1	0.4	2.4	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS33	-0.5	0.8	2.0	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS25	-0.5	0.7	1.7	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS18	-0.5	0.38	0.8	4.1	0.45	$V_{CCO} - 0.45$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS18 (-1L)	-0.5	0.33	0.71	4.1	0.45	$V_{CCO} - 0.45$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS18_JEDEC	-0.5	35% $V_{CCO}$	65% $V_{CCO}$	4.1	0.45	$V_{CCO} - 0.45$	<a href="#">Note 2</a>	<a href="#">Note 2</a>
LVCMOS15	-0.5	0.38	0.8	4.1	25% $V_{CCO}$	75% $V_{CCO}$	<a href="#">Note 3</a>	<a href="#">Note 3</a>
LVCMOS15 (-1L)	-0.5	0.33	0.71	4.1	25% $V_{CCO}$	75% $V_{CCO}$	<a href="#">Note 3</a>	<a href="#">Note 3</a>
LVCMOS15_JEDEC	-0.5	35% $V_{CCO}$	65% $V_{CCO}$	4.1	25% $V_{CCO}$	75% $V_{CCO}$	<a href="#">Note 3</a>	<a href="#">Note 3</a>
LVCMOS12	-0.5	0.38	0.8	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 4</a>	<a href="#">Note 4</a>
LVCMOS12 (-1L)	-0.5	0.33	0.71	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 4</a>	<a href="#">Note 4</a>
LVCMOS12_JEDEC	-0.5	35% $V_{CCO}$	65% $V_{CCO}$	4.1	0.4	$V_{CCO} - 0.4$	<a href="#">Note 4</a>	<a href="#">Note 4</a>
PCI33_3	-0.5	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.5$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
PCI66_3	-0.5	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.5$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
I2C	-0.5	25% $V_{CCO}$	70% $V_{CCO}$	4.1	20% $V_{CCO}$	-	3	-
SMBUS	-0.5	0.8	2.1	4.1	0.4	-	4	-
SDIO	-0.5	12.5% $V_{CCO}$	75% $V_{CCO}$	4.1	12.5% $V_{CCO}$	75% $V_{CCO}$	0.1	-0.1
MOBILE_DDR	-0.5	20% $V_{CCO}$	80% $V_{CCO}$	4.1	10% $V_{CCO}$	90% $V_{CCO}$	0.1	-0.1
HSTL_I	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	8	-8
HSTL_II	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	16	-16
HSTL_III	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	24	-8
HSTL_I_18	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	11	-11
HSTL_II_18	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	22	-22
HSTL_III_18	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	0.4	$V_{CCO} - 0.4$	30	-11
SSTL3_I	-0.5	$V_{REF} - 0.2$	$V_{REF} + 0.2$	4.1	$V_{TT} - 0.6$	$V_{TT} + 0.6$	8	-8
SSTL3_II	-0.5	$V_{REF} - 0.2$	$V_{REF} + 0.2$	4.1	$V_{TT} - 0.8$	$V_{TT} + 0.8$	16	-16
SSTL2_I	-0.5	$V_{REF} - 0.15$	$V_{REF} + 0.15$	4.1	$V_{TT} - 0.61$	$V_{TT} + 0.61$	8.1	-8.1
SSTL2_II	-0.5	$V_{REF} - 0.15$	$V_{REF} + 0.15$	4.1	$V_{TT} - 0.81$	$V_{TT} + 0.81$	16.2	-16.2
SSTL18_I	-0.5	$V_{REF} - 0.125$	$V_{REF} + 0.125$	4.1	$V_{TT} - 0.47$	$V_{TT} + 0.47$	6.7	-6.7
SSTL18_II	-0.5	$V_{REF} - 0.125$	$V_{REF} + 0.125$	4.1	$V_{TT} - 0.60$	$V_{TT} + 0.60$	13.4	-13.4
SSTL15_II	-0.5	$V_{REF} - 0.1$	$V_{REF} + 0.1$	4.1	$V_{TT} - 0.4$	$V_{TT} + 0.4$	13.4	-13.4

#### Notes:

- Tested according to relevant specifications.
- Using drive strengths of 2, 4, 6, 8, 12, 16, or 24 mA.
- Using drive strengths of 2, 4, 6, 8, 12, or 16 mA.
- Using drive strengths of 2, 4, 6, 8, or 12 mA.
- For more information, refer to [UG381: Spartan-6 FPGA SelectIO Resources User Guide](#).

Table 14: GTP Transceiver Current Supply (per Lane)

Symbol	Description	Typ <sup>(1)</sup>	Max	Units
I <sub>MGTAVCC</sub>	GTP transceiver internal analog supply current	40.4	Note 2	mA
I <sub>MGTAVTTX</sub>	GTP transmitter termination supply current	27.4		mA
I <sub>MGTAVTRX</sub>	GTP receiver termination supply current	13.6		mA
I <sub>MGTAVCCPLL</sub>	GTP transmitter and receiver PLL supply current	28.7		mA
R <sub>MGTRREF</sub>	Precision reference resistor for internal calibration termination	50.0 ± 1% tolerance		Ω

**Notes:**

1. Typical values are specified at nominal voltage, 25°C, with a 2.5 Gb/s line rate, with a shared PLL use mode.
2. Values for currents of other transceiver configurations and conditions can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.

Table 15: GTP Transceiver Quiescent Supply Current (per Lane)<sup>(1)(2)(3)(4)</sup>

Symbol	Description	Typ <sup>(5)</sup>	Max	Units
I <sub>MGTAVCCQ</sub>	Quiescent MGTAVCC supply current	1.7	Note 2	mA
I <sub>MGTAVTTXQ</sub>	Quiescent MGTAVTTX supply current	0.1		mA
I <sub>MGTAVTRXQ</sub>	Quiescent MGTAVTRX supply current	1.2		mA
I <sub>MGTAVCCPLQ</sub>	Quiescent MGTAVCCPLL supply current	1.0		mA

**Notes:**

1. Device powered and unconfigured.
2. Currents for conditions other than values specified in this table can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.
3. GTP transceiver quiescent supply current for an entire device can be calculated by multiplying the values in this table by the number of available GTP transceivers.
4. Does not include power-up MGTAVTTRCAL supply current during device configuration.
5. Typical values are specified at nominal voltage, 25°C.

## GTP Transceiver DC Input and Output Levels

Table 16 summarizes the DC output specifications of the GTP transceivers in Spartan-6 FPGAs. Figure 1 shows the single-ended output voltage swing. Figure 2 shows the peak-to-peak differential output voltage.

Consult [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) for further details.

Table 16: GTP Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
DV <sub>PPIN</sub>	Differential peak-to-peak input voltage	External AC coupled	140	—	2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled MGTAVTTRX = 1.2V	-400	—	MGTAVTTRX	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled MGTAVTTRX = 1.2V	—	3/4 MGTAVTTRX	—	mV
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to maximum setting	—	—	1000	mV
V <sub>SEOUT</sub>	Single-ended output voltage <sup>(1)</sup>	—	—	—	500	mV
V <sub>CMOUTDC</sub>	Common mode output voltage	Equation based	MGTAVTTX - V <sub>SEOUT</sub> /2			mV
R <sub>IN</sub>	Differential input resistance	—	80	100	130	Ω
R <sub>OUT</sub>	Differential output resistance	—	80	100	130	Ω
T <sub>OSKEW</sub>	Transmitter output skew	—	—	—	15	ps
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>	—	75	100	200	nF

**Notes:**

- The output swing and preemphasis levels are programmable using the attributes discussed in [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) and can result in values lower than reported in this table.
- Other values can be used as appropriate to conform to specific protocols and standards.

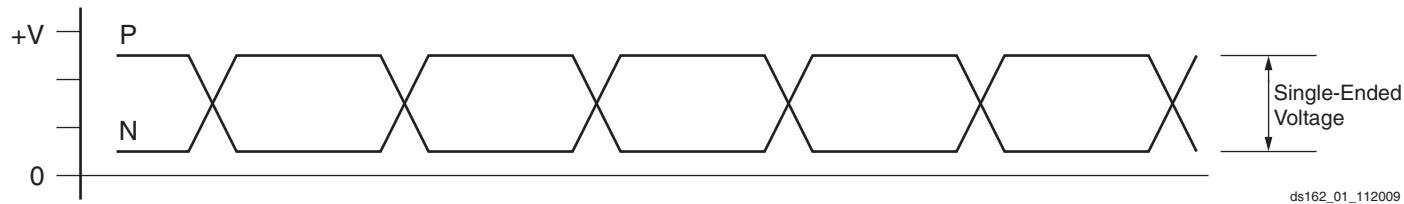


Figure 1: Single-Ended Peak-to-Peak Voltage

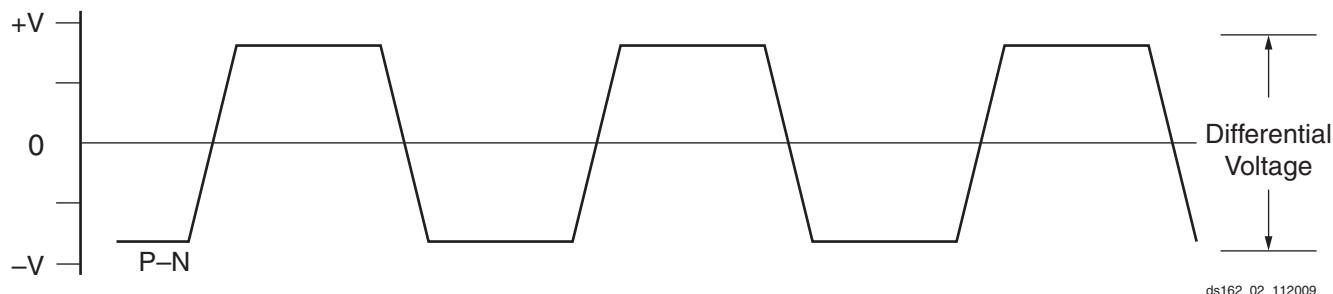


Figure 2: Differential Peak-to-Peak Voltage

Table 17 summarizes the DC specifications of the clock input of the GTP transceiver. Consult [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#) for further details.

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
LVCMOS33, Fast, 8 mA	1.34	1.46	1.59	1.82	2.07	2.21	2.41	3.03	2.07	2.21	2.41	3.03	ns	
LVCMOS33, Fast, 12 mA	1.34	1.46	1.59	1.82	1.65	1.79	1.99	2.62	1.65	1.79	1.99	2.62	ns	
LVCMOS33, Fast, 16 mA	1.34	1.46	1.59	1.82	1.65	1.79	1.99	2.62	1.65	1.79	1.99	2.62	ns	
LVCMOS33, Fast, 24 mA	1.34	1.46	1.59	1.82	1.65	1.79	1.99	2.62	1.65	1.79	1.99	2.62	ns	
LVCMOS25, QUIETIO, 2 mA	0.82	0.94	1.07	1.31	4.81	4.95	5.15	5.79	4.81	4.95	5.15	5.79	ns	
LVCMOS25, QUIETIO, 4 mA	0.82	0.94	1.07	1.31	3.70	3.84	4.04	4.66	3.70	3.84	4.04	4.66	ns	
LVCMOS25, QUIETIO, 6 mA	0.82	0.94	1.07	1.31	3.46	3.60	3.80	4.38	3.46	3.60	3.80	4.38	ns	
LVCMOS25, QUIETIO, 8 mA	0.82	0.94	1.07	1.31	3.20	3.34	3.54	4.12	3.20	3.34	3.54	4.12	ns	
LVCMOS25, QUIETIO, 12 mA	0.82	0.94	1.07	1.31	2.83	2.97	3.17	3.75	2.83	2.97	3.17	3.75	ns	
LVCMOS25, QUIETIO, 16 mA	0.82	0.94	1.07	1.31	2.64	2.78	2.98	3.64	2.64	2.78	2.98	3.64	ns	
LVCMOS25, QUIETIO, 24 mA	0.82	0.94	1.07	1.31	2.45	2.59	2.79	3.42	2.45	2.59	2.79	3.42	ns	
LVCMOS25, Slow, 2 mA	0.82	0.94	1.07	1.31	3.78	3.92	4.12	4.76	3.78	3.92	4.12	4.76	ns	
LVCMOS25, Slow, 4 mA	0.82	0.94	1.07	1.31	2.79	2.93	3.13	3.73	2.79	2.93	3.13	3.73	ns	
LVCMOS25, Slow, 6 mA	0.82	0.94	1.07	1.31	2.73	2.87	3.07	3.66	2.73	2.87	3.07	3.66	ns	
LVCMOS25, Slow, 8 mA	0.82	0.94	1.07	1.31	2.48	2.62	2.82	3.42	2.48	2.62	2.82	3.42	ns	
LVCMOS25, Slow, 12 mA	0.82	0.94	1.07	1.31	2.01	2.15	2.35	2.95	2.01	2.15	2.35	2.95	ns	
LVCMOS25, Slow, 16 mA	0.82	0.94	1.07	1.31	2.01	2.15	2.35	2.95	2.01	2.15	2.35	2.95	ns	
LVCMOS25, Slow, 24 mA	0.82	0.94	1.07	1.31	2.01	2.15	2.35	2.94	2.01	2.15	2.35	2.94	ns	
LVCMOS25, Fast, 2 mA	0.82	0.94	1.07	1.31	3.35	3.49	3.69	4.31	3.35	3.49	3.69	4.31	ns	
LVCMOS25, Fast, 4 mA	0.82	0.94	1.07	1.31	2.25	2.39	2.59	3.22	2.25	2.39	2.59	3.22	ns	
LVCMOS25, Fast, 6 mA	0.82	0.94	1.07	1.31	2.09	2.23	2.43	3.05	2.09	2.23	2.43	3.05	ns	
LVCMOS25, Fast, 8 mA	0.82	0.94	1.07	1.31	2.02	2.16	2.36	2.98	2.02	2.16	2.36	2.98	ns	
LVCMOS25, Fast, 12 mA	0.82	0.94	1.07	1.31	1.56	1.70	1.90	2.52	1.56	1.70	1.90	2.52	ns	
LVCMOS25, Fast, 16 mA	0.82	0.94	1.07	1.31	1.56	1.70	1.90	2.52	1.56	1.70	1.90	2.52	ns	
LVCMOS25, Fast, 24 mA	0.82	0.94	1.07	1.31	1.56	1.70	1.90	2.52	1.56	1.70	1.90	2.52	ns	
LVCMOS18, QUIETIO, 2 mA	1.18	1.30	1.43	2.04	5.92	6.06	6.26	6.80	5.92	6.06	6.26	6.80	ns	
LVCMOS18, QUIETIO, 4 mA	1.18	1.30	1.43	2.04	4.74	4.88	5.08	5.63	4.74	4.88	5.08	5.63	ns	
LVCMOS18, QUIETIO, 6 mA	1.18	1.30	1.43	2.04	4.05	4.19	4.39	4.96	4.05	4.19	4.39	4.96	ns	
LVCMOS18, QUIETIO, 8 mA	1.18	1.30	1.43	2.04	3.71	3.85	4.05	4.63	3.71	3.85	4.05	4.63	ns	
LVCMOS18, QUIETIO, 12 mA	1.18	1.30	1.43	2.04	3.35	3.49	3.69	4.27	3.35	3.49	3.69	4.27	ns	
LVCMOS18, QUIETIO, 16 mA	1.18	1.30	1.43	2.04	3.20	3.34	3.54	4.14	3.20	3.34	3.54	4.14	ns	
LVCMOS18, QUIETIO, 24 mA	1.18	1.30	1.43	2.04	2.96	3.10	3.30	3.98	2.96	3.10	3.30	3.98	ns	
LVCMOS18, Slow, 2 mA	1.18	1.30	1.43	2.04	4.62	4.76	4.96	5.54	4.62	4.76	4.96	5.54	ns	
LVCMOS18, Slow, 4 mA	1.18	1.30	1.43	2.04	3.69	3.83	4.03	4.60	3.69	3.83	4.03	4.60	ns	
LVCMOS18, Slow, 6 mA	1.18	1.30	1.43	2.04	3.00	3.14	3.34	3.94	3.00	3.14	3.34	3.94	ns	
LVCMOS18, Slow, 8 mA	1.18	1.30	1.43	2.04	2.19	2.33	2.53	3.17	2.19	2.33	2.53	3.17	ns	
LVCMOS18, Slow, 12 mA	1.18	1.30	1.43	2.04	1.99	2.13	2.33	2.95	1.99	2.13	2.33	2.95	ns	
LVCMOS18, Slow, 16 mA	1.18	1.30	1.43	2.04	1.99	2.13	2.33	2.95	1.99	2.13	2.33	2.95	ns	

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices (Cont'd)

I/O Standard	T <sub>IOP1</sub>				T <sub>IOP0</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
LVCMOS12, Fast, 2 mA	0.91	1.03	1.16	1.51	3.46	3.60	3.80	4.44	3.46	3.60	3.80	4.44	ns	
LVCMOS12, Fast, 4 mA	0.91	1.03	1.16	1.51	2.35	2.49	2.69	3.30	2.35	2.49	2.69	3.30	ns	
LVCMOS12, Fast, 6 mA	0.91	1.03	1.16	1.51	1.79	1.93	2.13	2.75	1.79	1.93	2.13	2.75	ns	
LVCMOS12, Fast, 8 mA	0.91	1.03	1.16	1.51	1.68	1.82	2.02	2.64	1.68	1.82	2.02	2.64	ns	
LVCMOS12, Fast, 12 mA	0.91	1.03	1.16	1.51	1.66	1.80	2.00	2.62	1.66	1.80	2.00	2.62	ns	
LVCMOS12_JEDEC, QUIETIO, 2 mA	1.50	1.62	1.75	1.88	6.39	6.53	6.73	7.31	6.39	6.53	6.73	7.31	ns	
LVCMOS12_JEDEC, QUIETIO, 4 mA	1.50	1.62	1.75	1.88	4.98	5.12	5.32	5.88	4.98	5.12	5.32	5.88	ns	
LVCMOS12_JEDEC, QUIETIO, 6 mA	1.50	1.62	1.75	1.88	4.67	4.81	5.01	5.54	4.67	4.81	5.01	5.54	ns	
LVCMOS12_JEDEC, QUIETIO, 8 mA	1.50	1.62	1.75	1.88	4.23	4.37	4.57	5.22	4.23	4.37	4.57	5.22	ns	
LVCMOS12_JEDEC, QUIETIO, 12 mA	1.50	1.62	1.75	1.88	3.99	4.13	4.33	4.94	3.99	4.13	4.33	4.94	ns	
LVCMOS12_JEDEC, Slow, 2 mA	1.50	1.62	1.75	1.88	5.00	5.14	5.34	5.90	5.00	5.14	5.34	5.90	ns	
LVCMOS12_JEDEC, Slow, 4 mA	1.50	1.62	1.75	1.88	2.85	2.99	3.19	3.80	2.85	2.99	3.19	3.80	ns	
LVCMOS12_JEDEC, Slow, 6 mA	1.50	1.62	1.75	1.88	2.76	2.90	3.10	3.72	2.76	2.90	3.10	3.72	ns	
LVCMOS12_JEDEC, Slow, 8 mA	1.50	1.62	1.75	1.88	2.35	2.49	2.69	3.30	2.35	2.49	2.69	3.30	ns	
LVCMOS12_JEDEC, Slow, 12 mA	1.50	1.62	1.75	1.88	2.09	2.23	2.43	3.05	2.09	2.23	2.43	3.05	ns	
LVCMOS12_JEDEC, Fast, 2 mA	1.50	1.62	1.75	1.88	3.46	3.60	3.80	4.42	3.46	3.60	3.80	4.42	ns	
LVCMOS12_JEDEC, Fast, 4 mA	1.50	1.62	1.75	1.88	2.35	2.49	2.69	3.31	2.35	2.49	2.69	3.31	ns	
LVCMOS12_JEDEC, Fast, 6 mA	1.50	1.62	1.75	1.88	1.79	1.93	2.13	2.76	1.79	1.93	2.13	2.76	ns	
LVCMOS12_JEDEC, Fast, 8 mA	1.50	1.62	1.75	1.88	1.69	1.83	2.03	2.65	1.69	1.83	2.03	2.65	ns	
LVCMOS12_JEDEC, Fast, 12 mA	1.50	1.62	1.75	1.88	1.66	1.80	2.00	2.62	1.66	1.80	2.00	2.62	ns	

**Notes:**

1. The -1L values listed in this table are also applicable to the Spartan-6Q devices.
2. Devices with a -1L speed grade do not support Xilinx PCI IP.

Table 32: Output Delay Measurement Methodology (Cont'd)

Description	I/O Standard Attribute	R <sub>REF</sub> (Ω)	C <sub>REF</sub> <sup>(1)</sup> (pF)	V <sub>MEAS</sub> (V)	V <sub>REF</sub> (V)
SSTL, Class II, 2.5V	SSTL2_II	25	0	V <sub>REF</sub>	1.25
SSTL, Class II, 1.5V	SSTL15_II	25	0	V <sub>REF</sub>	0.75
LVDS (Low-Voltage Differential Signaling), 2.5V & 3.3V	LVDS_25, LVDS_33	100	0	0 <sup>(3)</sup>	—
BLVDS (Bus LVDS), 2.5V	BLVDS_25	Note 4	0	0 <sup>(3)</sup>	—
Mini-LVDS, 2.5V & 3.3V	MINI_LVDS_25, MINI_LVDS_33	100	0	0 <sup>(3)</sup>	—
RSDS (Reduced Swing Differential Signaling), 2.5V & 3.3V	RSDS_25, RSDS_33	100	0	0 <sup>(3)</sup>	—
TMDS (Transition Minimized Differential Signaling), 3.3V	TMDS_33	Note 5	0	0 <sup>(3)</sup>	—
PPDS (Point-to-Point Differential Signaling, 2.5V & 3.3V	PPDS_25, PPDS_33	100	0	0 <sup>(3)</sup>	—

**Notes:**

1. C<sub>REF</sub> is the capacitance of the probe, nominally 0 pF.
2. Per PCI specifications.
3. The value given is the differential output voltage.
4. See the *BLVDS Output Termination* section in [UG381, Spartan-6 FPGA SelectIO Resources User Guide](#).
5. See the *TMDS\_33 Termination* section in [UG381, Spartan-6 FPGA SelectIO Resources User Guide](#).

## Simultaneously Switching Outputs

Due to package electrical parasitics, a given package supports a limited number of simultaneous switching outputs (SSOs) when using fast, high-drive outputs. [Table 33](#) and [Table 34](#) provide guidelines for the recommended maximum allowable number of SSOs. These guidelines describe the maximum number of user I/O pins of an output signal standard that should simultaneously switch in the same direction, while maintaining a safe level of switching noise for that particular signal standard. Meeting these guidelines for the stated test conditions ensures that the FPGA operates free from the adverse effects of GND and power bounce.

For each device/package combination, [Table 33](#) provides the number of equivalent V<sub>CCO</sub>/GND pairs per bank. For each output signal standard and drive strength, [Table 34](#) recommends the maximum number of SSOs, switching in the same direction, allowed per V<sub>CCO</sub>/GND pair within an I/O bank. The guidelines are categorized by package style, slew rate, and output drive current. The number of SSOs are also specified by I/O bank. Multiply the appropriate numbers from each table to calculate the maximum number of SSOs allowed within an I/O bank. The guidelines assume that all pins within a bank use the same I/O standard. Exceeding these SSO guidelines can result in increased power or GND bounce, degraded signal integrity, or increased system jitter. For a given I/O standard, if the SSO limit per pair in [Table 34](#) is greater than the maximum I/O per pair in [Table 33](#), then there is no SSO limit for the exclusive use of that I/O standard.

The recommended maximum SSO values assume that the FPGA is soldered on a printed circuit board and that the board uses sound design practices. Due to the additional inductance introduced by the socket, the SSO values do not apply for FPGAs mounted in sockets. The SSO values assume that the V<sub>CCAUX</sub> is powered at 3.3V. Setting V<sub>CCAUX</sub> to 2.5V provides better SSO characteristics. For more detail, see [UG381: Spartan-6 FPGA SelectIO Resources User Guide](#).

Table 34: SSO Limit per V<sub>CCO</sub>/GND Pair (Cont'd)

V <sub>CCO</sub>	I/O Standard	Drive	Slew	SSO Limit per V <sub>CCO</sub> /GND Pair					
				All TQG144, CPG196, CSG225, FT(G)256, and LX devices in CSG324		All CS(G)484, FG(G)484, FG(G)676, FG(G)900, and LXT devices in CSG324			
				Bank 0/2	Bank 1/3	Bank 0/2	Bank 1/3/4/5		
3.3V	LVTTL	2	Fast	53	65	53	62		
			Slow	70	80	70	73		
			QuietIO	79	89	79	91		
		4	Fast	23	30	23	27		
			Slow	34	41	34	37		
			QuietIO	44	49	44	46		
		6	Fast	16	21	16	20		
			Slow	21	28	21	25		
			QuietIO	34	39	34	34		
		8	Fast	12	16	12	15		
			Slow	16	22	16	19		
			QuietIO	27	28	27	24		
		12	Fast	1	3	1	1		
			Slow	2	5	2	4		
			QuietIO	2	10	2	8		
		16	Fast	1	3	1	1		
			Slow	1	7	1	2		
			QuietIO	3	11	3	8		
		24	Fast	1	2	1	1		
			Slow	2	5	2	2		
			QuietIO	8	9	8	8		
PCI33_3				18	19	18	19		
PCI66_3				18	19	18	19		
SSTL_3_I				5	8	5	8		
SSTL_3_II				3	5	3	3		
DIFF_SSTL_3_I				15	24	15	24		
DIFF_SSTL_3_II				9	15	9	9		
SDIO				17	18	17	15		

## Input/Output Logic Switching Characteristics

Table 35: ILOGIC2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold</b>						
T <sub>ICE0CK</sub> /T <sub>ICKCE0</sub>	CE0 pin Setup/Hold with respect to CLK	0.56/ -0.30	0.56/ -0.25	0.79/ -0.22	1.21/ -0.52	ns
T <sub>ISRCK</sub> /T <sub>ICKSR</sub>	SR pin Setup/Hold with respect to CLK	0.74/ -0.23	0.74/ -0.22	0.98/ -0.20	1.31/ -0.45	ns
T <sub>IDOCK</sub> /T <sub>IOCKD</sub>	D pin Setup/Hold with respect to CLK without Delay	1.19/ -0.83	1.36/ -0.83	1.73/ -0.83	2.18/ -1.77	ns
T <sub>IDOCKD</sub> /T <sub>IOCKDD</sub>	DDLY pin Setup/Hold with respect to CLK (using IODELAY2)	0.31/ 0.00	0.47/ 0.00	0.54/ 0.00	0.63/ -0.39	ns
<b>Combinatorial</b>						
T <sub>IDI</sub>	D pin to O pin propagation delay, no Delay	0.95	1.28	1.53	2.25	ns
T <sub>IDID</sub>	DDLY pin to O pin propagation delay (using IODELAY2)	0.23	0.39	0.44	0.74	ns
<b>Sequential Delays</b>						
T <sub>IDLO</sub>	D pin to Q pin using flip-flop as a latch without Delay	1.56	1.86	2.39	3.49	ns
T <sub>IDLOD</sub>	DDLY pin to Q1 pin using flip-flop as a latch (using IODELAY2)	0.68	0.97	1.20	1.94	ns
T <sub>ICKQ</sub>	CLK to Q outputs for XC devices	1.03	1.24	1.43	2.11	ns
	CLK to Q outputs for XA and XQ devices	1.38	N/A	1.78	2.11	ns
T <sub>TRQ_ILOGIC2</sub>	SR pin to Q outputs	1.81	1.81	2.50	3.05	ns

Table 36: OLOGIC2 Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Setup/Hold</b>						
T <sub>ODCK</sub> /T <sub>OCKD</sub>	D1/D2 pins Setup/Hold with respect to CLK	0.81/ -0.05	0.86/ -0.05	1.18/ 0.00	1.73/ -0.27	ns
T <sub>OOC ECK</sub> /T <sub>OCKOCE</sub>	OCE pin Setup/Hold with respect to CLK	0.75/ -0.10	0.75/ -0.10	1.01/ -0.05	1.66/ -0.23	ns
T <sub>OSRCK</sub> /T <sub>OCKSR</sub>	SR pin Setup/Hold with respect to CLK	0.70/ -0.28	0.79/ -0.28	1.03/ -0.23	1.39/ -0.47	ns
T <sub>OTCK</sub> /T <sub>OCKT</sub>	T1/T2 pins Setup/Hold with respect to CLK	0.24/ -0.08	0.56/ -0.06	0.83/ -0.01	0.99/ -0.19	ns
T <sub>OTCECK</sub> /T <sub>OCKTCE</sub>	TCE pin Setup/Hold with respect to CLK	0.58/ -0.06	0.72/ -0.06	1.18/ -0.01	1.51/ -0.13	ns
<b>Sequential Delays</b>						
T <sub>OCKQ</sub>	CLK to OQ/TQ out for XC devices	0.48	0.51	0.74	0.74	ns
	CLK to OQ/TQ out for XA and XQ devices	0.85	N/A	1.16	0.74	ns
T <sub>TRQ_OLOGIC2</sub>	SR pin to OQ/TQ out	1.81	1.81	2.50	3.05	ns

Table 44: DSP48A1 Switching Characteristics (Cont'd)

Symbol	Description	Pre-adder	Multiplier	Post-adder	Speed Grade				Units
					-3	-3N	-2	-1L	
$T_{DSPDCK\_OPMODE\_PREG}$ / $T_{DSPCKD\_OPMODE\_PREG}$	OPMODE input to P register CLK	Yes	Yes	Yes	6.21/ -0.84	7.27/ -0.84	7.27/ -0.84	10.43/ -0.84	ns
		No	Yes	Yes	1.69/ -0.87	1.98/ -0.87	1.98/ -0.87	3.62/ -0.87	ns
		No	No	Yes	2.09/ -0.22	2.30/ -0.22	2.30/ -0.22	3.79/ -0.22	ns
<b>Clock to Out from Output Register Clock to Output Pin</b>									
$T_{DSPCKO\_P\_PREG}$	CLK (PREG) to P output	N/A	N/A	N/A	1.20	1.34	1.34	1.90	ns
<b>Clock to Out from Pipeline Register Clock to Output Pins</b>									
$T_{DSPCKO\_P\_MREG}$	CLK (MREG) to P output	N/A	N/A	Yes	3.38	3.95	3.95	5.83	ns
<b>Clock to Out from Input Register Clock to Output Pins</b>									
$T_{DSPCKO\_P\_A1REG}$	CLK (A1REG) to P output	N/A	Yes	Yes	5.02	5.87	5.87	9.65	ns
$T_{DSPCKO\_P\_B1REG}$	CLK (B1REG) to P output	N/A	Yes	Yes	5.02	5.87	5.87	9.63	ns
$T_{DSPCKO\_P\_CREG}$	CLK (CREG) to P output	N/A	N/A	Yes	3.12	3.64	3.64	5.24	ns
$T_{DSPCKO\_P\_DREG}$	CLK (DREG) to P output	Yes	Yes	Yes	6.77	7.92	7.92	12.53	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>									
$T_{DSPDO\_A\_P}$	A input to P output	N/A	No	Yes	2.85	3.33	3.33	4.73	ns
		N/A	Yes	No <sup>(2)</sup>	3.35	3.93	3.93	6.74	ns
		N/A	Yes	Yes	4.56	5.22	5.22	8.94	ns
$T_{DSPDO\_B\_P}$	B input to P output	Yes	No	No <sup>(2)</sup>	3.22	3.76	3.76	5.55	ns
		Yes	Yes	No <sup>(2)</sup>	6.01	6.54	6.54	9.76	ns
		Yes	Yes	Yes	6.27	7.34	7.34	11.96	ns
$T_{DSPDO\_C\_P}$	C input to P output	N/A	N/A	Yes	2.69	3.15	3.15	4.68	ns
$T_{DSPDO\_D\_P}$	D input to P output	Yes	Yes	Yes	6.31	7.38	7.38	11.81	ns
$T_{DSPDO\_OPMODE\_P}$	OPMODE input to P output	Yes	Yes	Yes	6.43	7.52	7.52	11.84	ns
		No	Yes	Yes	4.84	5.66	5.66	9.25	ns
		No	No	Yes	3.11	3.49	3.49	5.03	ns
<b>Maximum Frequency</b>									
$F_{MAX}$	All registers used	Yes	Yes	Yes	390	333	333	213	MHz

**Notes:**

1. A Yes signifies that the component is in the path. A No signifies that the component is being bypassed. N/A signifies not applicable because no path exists.
2. Implemented in the post-adder by adding to zero.

Table 45: Device DNA Interface Port Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
T <sub>DNASSU</sub>	Setup time on SHIFT before the rising edge of CLK		7			ns, Min
T <sub>DNASH</sub>	Hold time on SHIFT after the rising edge of CLK		1			ns, Min
T <sub>DNADSU</sub>	Setup time on DIN before the rising edge of CLK		7			ns, Min
T <sub>DNADH</sub>	Hold time on DIN after the rising edge of CLK		1			ns, Min
T <sub>DNARSU</sub>	Setup time on READ before the rising edge of CLK		7			ns, Min
			1,000			ns, Max
T <sub>DNARH</sub>	Hold time on READ after the rising edge of CLK		1			ns, Min
T <sub>DNADCKO</sub>	Clock-to-output delay on DOUT after rising edge of CLK		0.5			ns, Min
			6			ns, Max
T <sub>DNACLKF</sub> <sup>(2)</sup>	CLK frequency		2			MHz, Max
T <sub>DNACLKL</sub>	CLK Low time		50			ns, Min
T <sub>DNACLKH</sub>	CLK High time		50			ns, Min

**Notes:**

1. The minimum READ pulse width is 8 ns, the maximum READ pulse width is 1  $\mu$ s.
2. Also applies to TCK when reading DNA through the boundary-scan port.

Table 46: Suspend Mode Switching Characteristics

Symbol	Description	Min	Max	Units
<b>Entering Suspend Mode</b>				
T <sub>SUSPENDHIGH_AWAKE</sub>	Rising edge of SUSPEND pin to falling edge of AWAKE pin without glitch filter	2.5	14	ns
T <sub>SUSPENDFILTER</sub>	Adjustment to SUSPEND pin rising edge parameters when glitch filter enabled	31	430	ns
T <sub>SUSPEND_GWE</sub>	Rising edge of SUSPEND pin until FPGA output pins drive their defined SUSPEND constraint behavior (without glitch filter)	–	15	ns
T <sub>SUSPEND_GTS</sub>	Rising edge of SUSPEND pin to write-protect lock on all writable clocked elements (without glitch filter)	–	15	ns
T <sub>SUSPEND_DISABLE</sub>	Rising edge of the SUSPEND pin to FPGA input pins and interconnect disabled (without glitch filter)	–	1500	ns
<b>Exiting Suspend Mode</b>				
T <sub>SUSPENDLOW_AWAKE</sub>	Falling edge of the SUSPEND pin to rising edge of the AWAKE pin. Does not include DCM or PLL lock time.	7	75	$\mu$ s
T <sub>SUSPEND_ENABLE</sub>	Falling edge of the SUSPEND pin to FPGA input pins and interconnect re-enabled	7	41	$\mu$ s
T <sub>AWAKE_GWE1</sub>	Rising edge of the AWAKE pin until write-protect lock released on all writable clocked elements, using <b>sw_clk:InternalClock</b> and <b>sw_gwe_cycle:1</b> .	–	80	ns
T <sub>AWAKE_GWE512</sub>	Rising edge of the AWAKE pin until write-protect lock released on all writable clocked elements, using <b>sw_clk:InternalClock</b> and <b>sw_gwe_cycle:512</b> .	–	20.5	$\mu$ s
T <sub>AWAKE_GTS1</sub>	Rising edge of the AWAKE pin until outputs return to the behavior described in the FPGA application, using <b>sw_clk:InternalClock</b> and <b>sw_gts_cycle:1</b> .	–	80	ns
T <sub>AWAKE_GTS512</sub>	Rising edge of the AWAKE pin until outputs return to the behavior described in the FPGA application, using <b>sw_clk:InternalClock</b> and <b>sw_gts_cycle:512</b> .	–	20.5	$\mu$ s
T <sub>SCP_AWAKE</sub>	Rising edge of SCP pins to rising edge of AWAKE pin	7	75	$\mu$ s

## Configuration Switching Characteristics

Table 47: Configuration Switching Characteristics<sup>(1)</sup>

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Power-up Timing Characteristics</b>						
T <sub>PL</sub> <sup>(2)</sup>	PROGRAM_B Latency	4	4	4	5	ms, Max
T <sub>POR</sub> <sup>(2)</sup>	Power-on reset (50 ms ramp time) <sup>(3)</sup>	5/30	5/34	5/40	5/40	ms, Min/Max
	Power-on reset (10 ms ramp time)	5/25	5/29	5/35	5/40	ms, Min/Max
T <sub>PROGRAM</sub>	PROGRAM_B Pulse Width	500	500	500	500	ns, Min
<b>Slave Serial Mode Programming Switching</b>						
T <sub>DCCCK/T<sub>CCKD</sub></sub>	DIN Setup/Hold, slave mode	6.0/1.0	6.0/1.0	6.0/1.0	8.0/2.0	ns, Min
T <sub>CCKO</sub>	CCLK to DOUT	12	12	12	17	ns, Max
F <sub>SCKK</sub>	Slave mode external CCLK	80	80	80	50	MHz, Max
<b>Slave SelectMAP Mode Programming Switching</b>						
T <sub>SMDCCK/T<sub>SMCKD</sub></sub>	SelectMAP Data Setup/Hold	6.0/1.0	6.0/1.0	6.0/1.0	8.0/2.0	ns, Min
T <sub>SMCSCCK/T<sub>SMCKCS</sub></sub>	CSI_B Setup/Hold	7.0/0.0	7.0/0.0	7.0/0.0	9.0/2.0	ns, Min
T <sub>SMWCCK/T<sub>SMCKW</sub></sub>	RDWR_B Setup/Hold	17.0/1.0	17.0/1.0	17.0/1.0	27.0/2.0	ns, Min
T <sub>SMCKCSO</sub>	CSO_B clock to out	16	16	16	26	ns, Max
T <sub>SMCO</sub>	CCLK to DATA out in readback	13	13	13	25	ns, Max
T <sub>SMCKBY</sub>	CCLK to BUSY out in readback	12	12	12	17	ns, Max
F <sub>SMCCK</sub>	Maximum CCLK frequency (LX4, LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T only)	50	50	50	25	MHz, Max
	Maximum CCLK frequency (LX100 and LX100T in x8 mode, LX150, and LX150T only)	40	40	40	20	MHz, Max
	Maximum CCLK frequency (LX100 and LX100T in x16 mode only)	35	35	35	20	MHz, Max
F <sub>RBCCK</sub>	Maximum Readback CCLK frequency, including block RAM (LX4, LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T only)	20	20	20	4	MHz, Max
	Maximum Readback CCLK frequency, ignoring block RAM (POST_CRC) (LX4, LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T only)	50	50	50	30	MHz, Max
	Maximum Readback CCLK frequency, including block RAM (LX100, LX100T, LX150, and LX150T only)	12	12	12	4	MHz, Max
	Maximum Readback CCLK frequency, ignoring block RAM (POST_CRC) (LX100, LX100T, LX150, and LX150T only)	35	35	35	20	MHz, Max
<b>Boundary-Scan Port Timing Specifications</b>						
T <sub>TAPTCK</sub>	TMS and TDI Setup time before TCK	10	10	10	17	ns, Min
T <sub>TCKTAP</sub>	TMS and TDI Hold time after TCK	5.5	5.5	5.5	5.5	ns, Min
T <sub>TCKTDO</sub>	TCK falling edge to TDO output valid	6.5	6.5	6.5	8	ns, Max
T <sub>TCKH</sub>	TCK clock minimum High time	12	12	12	21	ns, Min
T <sub>TCKL</sub>	TCK clock minimum Low time	12	12	12	21	ns, Min
F <sub>TCK</sub>	Maximum configuration TCK clock frequency	33	33	33	18	MHz, Max
F <sub>TCKB</sub>	Maximum boundary-scan TCK clock frequency	33	33	33	18	MHz, Max
F <sub>TCKAES</sub>	Maximum AES key TCK clock frequency	2	2	2	2	MHz, Max

Table 57: Switching Characteristics for the Digital Frequency Synthesizer DFS (DCM\_CLKGEN)<sup>(1)</sup>

Symbol	Description	Speed Grade								Units	
		-3		-3N		-2		-1L			
		Min	Max	Min	Max	Min	Max	Min	Max		
<b>Output Frequency Ranges (DCM_CLKGEN)</b>											
CLKOUT_FREQ_FX	Frequency for the CLKFX and CLKFX180 outputs	5	375	5	375	5	333	5	200	MHz	
CLKOUT_FREQ_FXDV	Frequency for the CLKFXDV output	0.15625	187.5	0.15625	187.5	0.15625	166.5	0.15625	100	MHz	
<b>Output Clock Jitter<sup>(2)(3)</sup></b>											
CLKOUT_PER_JITT_FX	Period jitter at the CLKFX and CLKFX180 outputs.	Typical = ±[0.2% of CLKFX period + 100]								ps	
CLKOUT_PER_JITT_FXDV	Period jitter at the CLKFXDV output.	Typical = ±[0.2% of CLKFX period + 100]								ps	
CLKFX_FREEZE_VAR	CLKFX period change in free running oscillator mode at the same temperature. FCLKFX > 50 MHz	Maximum = ±3% of CLKFX period								ps	
	CLKFX period change in free running oscillator mode at the same temperature. FCLKFX < 50 MHz	Maximum = ±5% of CLKFX period								ps	
CLKFX_FREEZE_TEMP_SLOPE	CLKFX period will change in free oscillator mode over temperature. Add to CLKFX_FREEZE_VAR to determine total CLKFX period change. Percentage change for CLKFX period over 1°C.	Maximum = 0.1								%/°C	
<b>Duty Cycle<sup>(4)(5)</sup></b>											
CLKOUT_DUTY_CYCLE_FX	Duty cycle precision for the CLKFX and CLKFX180 outputs, including the BUFGMUX and clock tree duty-cycle distortion	Maximum = ±[1% of CLKFX period + 350]								ps	
CLKOUT_DUTY_CYCLE_FXDV	Duty cycle precision for the CLKFXDV outputs, including the BUFGMUX and clock tree duty-cycle distortion	Maximum = ±[1% of CLKFX period + 350]								ps	
<b>Lock Time</b>											
LOCK_FX <sup>(2)</sup>	The time from deassertion at the DCM's Reset input to the rising transition at its LOCKED output. The DFS asserts LOCKED when the CLKFX, CLKFX180, and CLKFXDV signals are valid. Lock time requires CLKFX_DIVIDE < F <sub>IN</sub> /(0.50 MHz) when: F <sub>CLKIN</sub> < 50 MHz	–	50	–	50	–	50	–	50	ms	
	when: F <sub>CLKIN</sub> > 50 MHz	–	5	–	5	–	5	–	5	ms	

Table 65: Global Clock Input to Output Delay With DCM in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> DCM in Source-Synchronous Mode.							
T <sub>CLOCKOFDCM_0</sub>	Global Clock and OUTFF <i>with</i> DCM	XC6SLX4	5.03	N/A	7.21	8.05	ns
		XC6SLX9	5.03	6.13	7.21	8.05	ns
		XC6SLX16	5.08	5.51	6.44	7.96	ns
		XC6SLX25	4.81	5.13	5.69	7.94	ns
		XC6SLX25T	4.81	5.13	5.69	N/A	ns
		XC6SLX45	5.26	5.69	6.63	7.92	ns
		XC6SLX45T	5.26	5.69	6.63	N/A	ns
		XC6SLX75	4.77	5.18	5.88	7.95	ns
		XC6SLX75T	4.77	5.18	5.88	N/A	ns
		XC6SLX100	4.72	5.11	5.76	8.59	ns
		XC6SLX100T	4.76	5.11	5.76	N/A	ns
		XC6SLX150	4.90	5.30	5.93	7.93	ns
		XC6SLX150T	4.90	5.30	5.93	N/A	ns
		XA6SLX4	5.35	N/A	7.21	N/A	ns
		XA6SLX9	5.35	N/A	7.21	N/A	ns
		XA6SLX16	5.42	N/A	6.44	N/A	ns
		XA6SLX25	5.13	N/A	5.69	N/A	ns
		XA6SLX25T	5.13	N/A	5.79	N/A	ns
		XA6SLX45	5.58	N/A	6.63	N/A	ns
		XA6SLX45T	5.58	N/A	6.63	N/A	ns
		XA6SLX75	5.09	N/A	5.87	N/A	ns
		XA6SLX75T	5.09	N/A	5.87	N/A	ns
		XA6SLX100	N/A	N/A	6.44	N/A	ns
		XQ6SLX75	N/A	N/A	5.87	7.95	ns
		XQ6SLX75T	5.09	N/A	5.87	N/A	ns
		XQ6SLX150	N/A	N/A	6.06	7.93	ns
		XQ6SLX150T	5.50	N/A	6.06	N/A	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. DCM output jitter is already included in the timing calculation.

Table 67: Global Clock Input to Output Delay With PLL in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> PLL in Source-Synchronous Mode.							
T <sub>CLOCKPLL_0</sub>	Global Clock and OUTFF <i>with</i> PLL	XC6SLX4	5.49	N/A	7.44	8.55	ns
		XC6SLX9	5.49	6.29	7.44	8.55	ns
		XC6SLX16	5.23	5.77	6.79	8.21	ns
		XC6SLX25	5.00	5.35	6.10	8.54	ns
		XC6SLX25T	5.00	5.35	6.10	N/A	ns
		XC6SLX45	5.59	6.03	7.02	8.39	ns
		XC6SLX45T	5.59	6.03	7.02	N/A	ns
		XC6SLX75	4.96	5.41	6.22	8.32	ns
		XC6SLX75T	4.96	5.41	6.22	N/A	ns
		XC6SLX100	4.97	5.42	6.21	9.08	ns
		XC6SLX100T	5.01	5.42	6.21	N/A	ns
		XC6SLX150	4.59	5.06	5.86	8.13	ns
		XC6SLX150T	4.59	5.06	5.86	N/A	ns
		XA6SLX4	5.79	N/A	7.32	N/A	ns
		XA6SLX9	5.79	N/A	7.32	N/A	ns
		XA6SLX16	5.56	N/A	6.66	N/A	ns
		XA6SLX25	5.40	N/A	5.97	N/A	ns
		XA6SLX25T	5.40	N/A	6.07	N/A	ns
		XA6SLX45	5.89	N/A	6.90	N/A	ns
		XA6SLX45T	5.89	N/A	6.90	N/A	ns
		XA6SLX75	5.27	N/A	6.12	N/A	ns
		XA6SLX75T	5.27	N/A	6.12	N/A	ns
		XA6SLX100	N/A	N/A	6.80	N/A	ns
		XQ6SLX75	N/A	N/A	6.12	8.32	ns
		XQ6SLX75T	5.27	N/A	6.12	N/A	ns
		XQ6SLX150	N/A	N/A	5.88	8.13	ns
		XQ6SLX150T	5.21	N/A	5.88	N/A	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. PLL output jitter is included in the timing calculation.

Table 73: Global Clock Setup and Hold With DCM in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSDCM0</sub> / T <sub>PHDCM0</sub>	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in Source-Synchronous Mode	XC6SLX4	0.71/0.65	N/A	0.72/1.22	1.58/1.18	ns
		XC6SLX9	0.71/0.69	0.71/1.19	0.72/1.36	1.58/1.18	ns
		XC6SLX16	0.86/0.52	0.92/0.57	1.04/0.60	1.02/1.06	ns
		XC6SLX25	0.84/0.58	0.90/0.59	1.01/0.59	1.58/1.07	ns
		XC6SLX25T	0.84/0.58	0.90/0.59	1.01/0.59	N/A	ns
		XC6SLX45	0.85/0.70	0.90/0.76	0.98/0.79	1.34/1.34	ns
		XC6SLX45T	0.85/0.70	0.90/0.76	0.98/0.79	N/A	ns
		XC6SLX75	1.00/0.62	1.06/0.63	1.15/0.63	1.65/1.46	ns
		XC6SLX75T	1.00/0.71	1.06/0.72	1.15/0.72	N/A	ns
		XC6SLX100	0.81/0.68	0.81/0.69	0.94/0.69	1.42/2.07	ns
		XC6SLX100T	0.81/0.68	0.81/0.69	0.94/0.69	N/A	ns
		XC6SLX150	0.68/0.98	0.69/0.99	0.79/0.99	1.45/1.60	ns
		XC6SLX150T	0.68/0.98	0.69/0.99	0.79/0.99	N/A	ns
		XA6SLX4	0.81/0.74	N/A	0.72/1.36	N/A	ns
		XA6SLX9	0.81/0.74	N/A	0.72/1.36	N/A	ns
		XA6SLX16	1.01/0.56	N/A	1.04/0.60	N/A	ns
		XA6SLX25	0.94/0.76	N/A	1.06/0.77	N/A	ns
		XA6SLX25T	0.94/0.76	N/A	1.14/0.77	N/A	ns
		XA6SLX45	0.86/0.74	N/A	0.98/0.78	N/A	ns
		XA6SLX45T	0.86/0.74	N/A	0.98/0.78	N/A	ns
		XA6SLX75	1.02/0.71	N/A	1.15/0.72	N/A	ns
		XA6SLX75T	1.02/0.71	N/A	1.15/0.72	N/A	ns
		XA6SLX100	N/A	N/A	1.37/0.75	N/A	ns
		XQ6SLX75	N/A	N/A	1.15/0.72	1.65/1.46	ns
		XQ6SLX75T	1.02/0.71	N/A	1.15/0.72	N/A	ns
		XQ6SLX150	N/A	N/A	0.79/1.15	1.45/1.60	ns
		XQ6SLX150T	0.73/1.15	N/A	0.79/1.15	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include DCM CLK0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 76: Global Clock Setup and Hold With DCM and PLL in System-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
$T_{PSDCMPLL}/T_{PHDCMPLL}$	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in System-Synchronous Mode and PLL in DCM2PLL Mode.	XC6SLX4	1.16/0.49	N/A	1.39/0.49	2.36/0.59	ns
		XC6SLX9	1.16/0.44	1.37/0.44	1.39/0.44	2.36/0.59	ns
		XC6SLX16	1.44/-0.08	1.49/-0.04	1.62/-0.04	2.06/0.55	ns
		XC6SLX25	1.52/0.42	1.65/0.42	1.83/0.42	2.52/0.43	ns
		XC6SLX25T	1.52/0.42	1.65/0.42	1.83/0.42	N/A	ns
		XC6SLX45	1.54/0.39	1.59/0.39	1.75/0.39	2.48/0.76	ns
		XC6SLX45T	1.54/0.39	1.59/0.39	1.75/0.39	N/A	ns
		XC6SLX75	1.72/0.41	1.80/0.41	1.99/0.41	2.60/0.75	ns
		XC6SLX75T	1.72/0.41	1.80/0.41	1.99/0.41	N/A	ns
		XC6SLX100	1.34/0.51	1.46/0.51	1.64/0.51	2.12/0.90	ns
		XC6SLX100T	1.34/0.51	1.46/0.51	1.64/0.51	N/A	ns
		XC6SLX150	1.30/0.60	1.40/0.60	1.55/0.60	2.57/0.97	ns
		XC6SLX150T	1.30/0.60	1.40/0.60	1.55/0.60	N/A	ns
		XA6SLX4	1.58/0.37	N/A	1.58/0.37	N/A	ns
		XA6SLX9	1.58/0.37	N/A	1.58/0.37	N/A	ns
		XA6SLX16	2.67/0.35	N/A	2.67/0.17	N/A	ns
		XA6SLX25	1.74/0.27	N/A	1.95/0.27	N/A	ns
		XA6SLX25T	1.74/0.27	N/A	2.03/0.27	N/A	ns
		XA6SLX45	1.58/0.29	N/A	1.87/0.29	N/A	ns
		XA6SLX45T	1.58/0.29	N/A	1.87/0.29	N/A	ns
		XA6SLX75	1.74/0.24	N/A	2.11/0.24	N/A	ns
		XA6SLX75T	1.74/0.24	N/A	2.11/0.24	N/A	ns
		XA6SLX100	N/A	N/A	2.64/0.82	N/A	ns
		XQ6SLX75	N/A	N/A	2.11/0.24	2.60/0.75	ns
		XQ6SLX75T	1.74/0.24	N/A	2.11/0.24	N/A	ns
		XQ6SLX150	N/A	N/A	1.67/0.70	2.57/0.97	ns
		XQ6SLX150T	1.50/0.70	N/A	1.67/0.70	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include CMT jitter; DCM CLK0 driving PLL, PLL CLKOUT0 driving BUFG.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 77: Global Clock Setup and Hold With DCM and PLL in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
Example Data Input Set-Up and Hold Times Relative to a Forwarded Clock Input Pin, <sup>(1)</sup> Using DCM, PLL, and Global Clock Buffer for the LVCMS25 standard.							
$T_{PSDCMPLL\_0'}$ $T_{PHDCMPLL\_0}$	No Delay Global Clock and IFF <sup>(2)</sup> with DCM in Source-Synchronous Mode and PLL in DCM2PLL Mode.	XC6SLX4	0.43/1.07	N/A	0.43/1.43	1.10/1.67	ns
		XC6SLX9	0.43/1.03	0.45/1.14	0.45/1.43	1.10/1.67	ns
		XC6SLX16	0.74/0.93	0.74/1.12	0.74/1.21	0.77/1.35	ns
		XC6SLX25	0.67/1.02	0.76/1.11	0.84/1.18	1.23/1.46	ns
		XC6SLX25T	0.67/1.02	0.76/1.11	0.84/1.18	N/A	ns
		XC6SLX45	0.65/0.99	0.65/1.04	0.71/1.12	1.18/1.58	ns
		XC6SLX45T	0.65/1.00	0.65/1.04	0.71/1.12	N/A	ns
		XC6SLX75	0.86/1.01	0.88/1.06	0.94/1.14	1.29/1.67	ns
		XC6SLX75T	0.86/1.01	0.88/1.06	0.94/1.14	N/A	ns
		XC6SLX100	0.50/1.10	0.56/1.10	0.61/1.17	0.84/2.24	ns
		XC6SLX100T	0.50/1.10	0.56/1.10	0.61/1.17	N/A	ns
		XC6SLX150	0.45/1.28	0.47/1.28	0.52/1.28	1.27/1.56	ns
		XC6SLX150T	0.45/1.28	0.47/1.28	0.52/1.28	N/A	ns
		XA6SLX4	0.74/1.00	N/A	0.74/1.43	N/A	ns
		XA6SLX9	0.74/1.00	N/A	0.74/1.43	N/A	ns
		XA6SLX16	1.81/1.15	N/A	1.81/1.03	N/A	ns
		XA6SLX25	0.89/1.01	N/A	0.96/1.05	N/A	ns
		XA6SLX25T	0.89/1.01	N/A	1.04/1.15	N/A	ns
		XA6SLX45	0.69/0.95	N/A	0.83/0.96	N/A	ns
		XA6SLX45T	0.69/0.95	N/A	0.83/0.96	N/A	ns
		XA6SLX75	0.88/0.94	N/A	1.06/0.96	N/A	ns
		XA6SLX75T	0.88/0.94	N/A	1.06/0.96	N/A	ns
		XA6SLX100	N/A	N/A	1.55/1.33	N/A	ns
		XQ6SLX75	N/A	N/A	1.06/0.96	1.29/1.67	ns
		XQ6SLX75T	0.88/0.94	N/A	1.06/0.96	N/A	ns
		XQ6SLX150	N/A	N/A	0.64/1.30	1.27/1.56	ns
		XQ6SLX150T	0.58/1.30	N/A	0.64/1.30	N/A	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. The timing values were measured using the fine-phase adjustment feature of the DCM. These measurements include CMT jitter; DCM CLK0 driving PLL, PLL CLKOUT0 driving BUFG. Package skew is not included in these measurements.
2. IFF = Input Flip-Flop

Date	Version	Description of Revisions
06/14/10	1.5	<p>In <a href="#">Table 2</a>, added note 5 and added temperature range to <math>V_{FS}</math> and <math>R_{FUSE}</math>. Removed speed grade delineation, revised <math>I_{RPD}</math> description, and updated note 2 in <a href="#">Table 4</a>. Added note 2 to <a href="#">Table 7</a>. Added DIFF_MOBILE_DDR to <a href="#">Table 8</a> and <a href="#">Table 10</a>. Added note 4 to <a href="#">Table 15</a>. Changed minimum <math>DV_{PPIN}</math> in <a href="#">Table 16</a>. Updated <math>F_{GTPDRPCLK}</math> in <a href="#">Table 19</a>. Increased maximum <math>T_{LLSKEW}</math> in <a href="#">Table 22</a>. Updated descriptions and added data to <a href="#">Table 23</a>. Removed note 1 and added new data to the Networking Applications section in <a href="#">Table 25</a>. Updated <a href="#">Table 26</a> and <a href="#">Table 27</a> to the data in ISE v12.1 software with speed specification v1.08. In <a href="#">Table 28</a>, added DIFF_MOBILE_DDR and updated -4 speed grade data. Updated the maximum I/O pairs per bank in <a href="#">Table 33</a>. Updated note 2 on <a href="#">Table 39</a>. Revised the <math>F_{MAX}</math> in <a href="#">Table 44</a>. In <a href="#">Table 47</a>, updated description for <math>T_{SMCKCSO}</math>, revised values for <math>T_{POR}</math> and added Min value, added <math>T_{BPICCK}</math> and <math>T_{SPIICCK}</math>. Also in <a href="#">Table 47</a>, added device dependencies to <math>F_{SMCCK}</math> and <math>F_{RBCCCK}</math>. Updated and added data to <a href="#">Table 63</a> through <a href="#">Table 78</a>, and <a href="#">Table 81</a>. In <a href="#">Table 79</a>, added data on the XC6SLX45-FG(G)676 and revised the XC6SLX45T and XC6SLX150T values.</p> <p>The following changes to this specification are addressed in the product change notice <a href="#">XCN10024</a>, <i>MCB Performance and JTAG Revision Code for Spartan-6 LX16 and LX45 FPGAs</i>.</p> <p>In <a href="#">Table 2</a>, revised the <math>V_{CCINT}</math> to add the memory controller block extended performance specifications. In <a href="#">Table 25</a>, changed the standard specifications and added extended performance specifications for the memory controller block and note 2. Added note 4 and updated values in <a href="#">Table 34</a>.</p>
06/24/10	1.6	<p>Production release of XC6SLX45T (-2 and -3 speed grades), XC6SLX16 and XC6SLX45 (-3 speed grade) devices which includes changes to <a href="#">Table 26</a> and <a href="#">Table 27</a> (ISE v12.1 software with speed specification v1.08).</p> <p>Added the -3N speed grade, which designates Spartan-6 devices that do not support MCB functionality. This includes changes to <a href="#">Table 2</a> (note 2), <a href="#">Table 25</a> (note 4), and <a href="#">Switching Characteristics (Table 26)</a>.</p> <p>Updated <a href="#">Simultaneously Switching Outputs</a> discussion. Added -3 speed grade values for <math>T_{TAP}</math> and <math>F_{MINCAL}</math> values in <a href="#">Table 39</a>. In <a href="#">Table 40</a>, updated <math>T_{RPW}</math> (-2 and -3 speed grade) values and <math>F_{TOG}</math> (-3 speed grade) values. In <a href="#">Table 48</a>, updated <math>T_{GIO}</math> (-2 and -3 speed grade) values. Updated -3 values in spread spectrum section of <a href="#">Table 57</a>.</p>
07/16/10	1.7	<p>Production release of specific devices listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.2 software with speed specification v1.11. Added note 4 advising designers of the patch which contains v1.11. Also updated the -1L speed specification to v1.04. Updated numerous -4 and -1L values. Added -4 <math>T_{TAP}</math> values and <math>F_{MINCAL}</math> to <a href="#">Table 39</a>. Revised <math>T_{CINCK}/T_{CKCIN}</math> in <a href="#">Table 40</a>. In <a href="#">Table 41</a>, revised <math>T_{SHCKO}</math>. In <a href="#">Table 42</a>, revised <math>T_{REG}</math>. Added new -1L values to <a href="#">Table 47</a>. Added and updated values in <a href="#">Table 79</a>.</p>
07/26/10	1.8	<p>Production release of XC6SLX25, XC6SLX25T, XC6SLX100 and XC6SLX100T in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.2 software with speed specification v1.11. Added note 7 to <a href="#">Table 2</a> and moved <math>V_{FS}</math> and <math>R_{FUSE}</math> to a new <a href="#">Table 3</a>. Added <math>I_{HS}</math> and note 4 to <a href="#">Table 4</a>. Added note 1 to <a href="#">Table 28</a>. Added and updated SSO limits per <math>V_{CCO}/GND</math> pairs in <a href="#">Table 34</a>. Added note 3 to <a href="#">Table 47</a>. In <a href="#">Table 54</a>, removed -1L specifications for CLKOUT_PER_JITT_DV1/2 and revised CLKIN_CLKFB_PHASE and CLKOUT_PHASE_DLL values. Updated note 3 in both <a href="#">Table 56</a> and <a href="#">Table 57</a>.</p>
08/23/10	1.9	<p>Updated values for <math>F_{GTPRANGE1}</math>, <math>F_{GTPRANGE2}</math>, and <math>F_{GPLLMIN}</math> in <a href="#">Table 18</a>. Revised -3 and -4 values in <a href="#">Table 21</a>. Removed the -1L speed grade readback support restriction and note 3 in <a href="#">Table 47</a>.</p>
11/05/10	1.10	<p>Production release of XC6SLX4 and XC6SLX9 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.3 software with speed specification v1.12 for the -2 speed grade available in the 12.3 Speed Files Patch. Added note 3 advising designers of the patch which contains v1.12.</p> <p>In <a href="#">Table 2</a>, added note 4. In <a href="#">Table 4</a>, added note 2. In <a href="#">Table 10</a>, added notes 2 and 3. In <a href="#">Table 44</a>, added note 2. In <a href="#">Table 47</a>, updated symbol for <math>T_{SMWCCK}/T_{SMCCCK}</math>, changed -1L values for <math>T_{USERCCLKH}</math> and <math>T_{USERCCLKL}</math>, and added and revised the modes for <math>F_{MCCK}</math> and <math>F_{SMCCK}</math>. In <a href="#">Table 53</a>, redefined and expanded description for CLKIN_FREQ_DLL and rewrote note 3. Updated title of <a href="#">Table 58</a>. Also in <a href="#">Table 78</a>, revised <math>T_{DCD\_CLK}</math> for XC6SLX150 and XC6SLX150T. Changed description of <math>T_{PSFD}/T_{PHFD}</math> in <a href="#">Table 71</a>.</p> <p>For the -1L speed grade, updated data sheet to ISE 12.3 software with speed specification v1.05 which revised the values in the following tables: <a href="#">Table 25</a>, <a href="#">Table 28</a>, <a href="#">Table 35</a>, <a href="#">Table 36</a>, <a href="#">Table 37</a>, <a href="#">Table 40</a> through <a href="#">Table 43</a>, <a href="#">Table 48</a> through <a href="#">Table 56</a>, <a href="#">Table 62</a> through <a href="#">Table 78</a>, <a href="#">Table 80</a>, and <a href="#">Table 81</a>. Updated <a href="#">Notice of Disclaimer</a>.</p>

Date	Version	Description of Revisions
01/10/11	1.11	<p>Production release of XC6SLX4 and XC6SLX9 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.4 software with speed specification v1.15 for the -4, -3, -3N, and -2 speed grades. Added note 3 to <a href="#">Table 27</a>. Also updated the -1L speed grade requirements to ISE v12.4 software with speed specification v1.06. Revised -3N definition throughout the document.</p> <p>Added note 4 to <a href="#">Table 2</a> and updated note 5. Added information on <math>V_{CCINT}</math> to note 1 in <a href="#">Table 5</a>. Updated Networking Applications -3 values in <a href="#">Table 25</a> to match improvements made in ISE v12.4. In <a href="#">Table 28</a>, added note 1 and revised the <math>T_{IOTP}</math> values for LVDS_33, LVDS_25, MINI_LVDS_33, MINI_LVDS_25, RSDS_33, RSDS_25, TMDS_33, PPDS_33, and PPDS_25. Added note 3 to <a href="#">Table 55</a>.</p>
02/11/11	1.12	<p>As described in <a href="#">XCN11008: Product Discontinuation Notice For Spartan-6 LXT -4 Devices</a>, the -4 speed specifications have been discontinued. As outlined in page 2 of the XCN, designers currently using -4 speed specifications should rerun timing analysis using the new -3 speed specifications before moving to a replacement device.</p> <p>Updated the networking applications section of <a href="#">Table 25</a>. Updated -2 speed specifications throughout document and added note 3 to <a href="#">Table 27</a> advising designers to use the -2 speed specification update (v1.17) with the ISE 12.4 software patch. Added <math>F_{CLKDIV}</math> to <a href="#">Table 37</a> and <a href="#">Table 38</a>. Updated note 2 in <a href="#">Table 39</a>. Updated units for <math>T_{SMCKCSO}</math> and <math>T_{BPICCO}</math> in <a href="#">Table 47</a>. Updated -1L in <a href="#">Table 71</a>. Removed Note 2: <i>Package delay information is available for these device/package combinations. This information can be used to deskew the package from Table 79.</i></p>
03/31/11	2.0	<p>Production release of XC6SLX45 in the -1L speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.1 software with -1L speed specification v1.06.</p> <p>In <a href="#">Table 39</a>, removed values in the -1L column and added note 3 as IODELAY2 only supports Tap0 for lower-power devices. Updated copyright <a href="#">page 1</a> and <a href="#">Notice of Disclaimer</a>.</p>
05/20/11	2.1	<p>Production release of XC6SLX100 and XC6SLX150 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.1 software with -1L speed specification v1.06. Updated <a href="#">Table 27</a> and <a href="#">Note 7</a> with changes per <a href="#">XCN11012: Speed File Change for -3N Devices</a>. Revised <a href="#">Switching Characteristics</a> section for speed specifications: v1.18 for -3, -3N, and -2; including improvements in <a href="#">Table 73</a> through <a href="#">Table 77</a> and <a href="#">Table 81</a>.</p> <p>Removed <i>Memory Controller Block</i> from the performance heading in <a href="#">Table 2</a> and revised <a href="#">Note 2</a>. In <a href="#">Table 4</a>, added <a href="#">Note 1</a> to <math>C_{IN}</math> and updated the description of <math>R_{IN\_TERM}</math>. Updated <a href="#">Note 1</a> in <a href="#">Table 5</a>. Updated <a href="#">Note 1</a> of <a href="#">Table 7</a>. In <a href="#">Table 25</a>, added and removed -1L specifications, increased the standard performance DDR3 specifications, removed the extended performance DDR3 row and updated <a href="#">Note 3</a> and <a href="#">Note 4</a>. Clarified the introductory information for <a href="#">Table 28</a> and <a href="#">Table 30</a>.</p> <p>In <a href="#">Table 32</a>: Revised <math>V_{MEAS}</math> value for LVCMOS12; revised <math>V_{REF}</math> for LVDS_25, LVDS_33, BLVDS_25, MINI_LVDS_25, MINI_LVDS_33, RSDS_25, and RSDS_33; revised <math>R_{REF}</math> for BLVDS_25 and TMDS_33; and added <a href="#">Note 4</a> and <a href="#">Note 5</a>. Updated <a href="#">Note 2</a> and <a href="#">Note 3</a> in <a href="#">Table 39</a>.</p> <p>In <a href="#">Table 47</a>, revised the values and description of <math>T_{POR}</math> including adding <a href="#">Note 3</a>. Also in <a href="#">Table 47</a>, augmented the description and added specifications for <math>F_{RBCK}</math> and removed XC6SLX4 from <math>F_{MCCK}</math> (maximum frequency, parallel mode (Master SelectMAP/BPI)). Added BUFGMUX to <a href="#">Table 48</a> title. Added <a href="#">Table 50</a>.</p> <p>In <a href="#">Table 52</a>, revised specifications for <math>T_{EXTFDVAR}</math> and <math>F_{INJITTER}</math>. In <a href="#">Table 54</a> removed the 5 MHz &lt; <math>CLKIN\_FREQ\_DLL</math> parameter in the <math>LOCK\_DLL</math> description. In both <a href="#">Table 56</a> and <a href="#">Table 57</a>, removed the 5 MHz &lt; <math>F_{CLKIN}</math> parameter in the <math>LOCK\_FX</math> description. In <a href="#">Table 58</a>, updated description for <math>PSCLK\_FREQ</math> and <math>PSCLK\_PULSE</math>.</p> <p>Revised title and symbol of <a href="#">Table 70</a>, added new speed specifications for -1L, and added <a href="#">Note 2</a>. Added <a href="#">Table 71</a>.</p>
07/11/11	2.2	<p>Added the Automotive XA Spartan-6 and Defense-grade Spartan-6Q devices to all appropriate tables while sometimes removing the XC6S nomenclature. Added expanded temperature range (Q) to all appropriate tables. Updated <math>T_{SOL}</math> packages in <a href="#">Table 1</a>. Added <math>R_{OUT\_TERM}</math> to <a href="#">Table 4</a>. Updated <a href="#">Note 2</a> on <a href="#">Table 13</a>.</p> <p>Production release of the XC6SLX4, XC6SLX9, XC6SLX16, XC6SLX25, XC6SLX75, XQ6SLX75, and XQ6SLX150 in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -1L speed specification v1.07.</p> <p>Production release of the XA6SLX16, XA6SLX25T, XA6SLX45, XA6SLX45T, XQ6SLX75, XQ6SLX75T, XQ6SLX150, and XQ6SLX150T in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19.</p> <p>Added <a href="#">Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices(1)</a>. Updated CS(G)484 from CSG484 throughout data sheet. Clarified <a href="#">Note 3</a> in <a href="#">Table 39</a>.</p>
08/08/11	2.3	Production release of the XA6SLX25, XA6SLX75, and XA6SLX75T in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19.